



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appln. No. 10/067,441

#8/Quadt B
J. Fred
11/10/03

In re Patent Application of

J. P. KOTOWSKI, ET AL.

Application No. 10/067,441

Filed: February 4, 2002

For: **INTEGRATED CIRCUIT AND
METHOD FOR TESTING SAME
USING SINGLE PIN TO CONTROL
TEST MODE AND NORMAL MODE
OPERATION**

Group Art Unit: 2824

Examiner: JUNG H. HUR

**RESPONSE TO OFFICE ACTION
MAILED ON SEPTEMBER 15,
2003**

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CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P. O. Box 1450, Alexandria, VA 22313-1450 on October 28, 2003.

GIRARD & EQUITZ LLP

Date: 10/28/03

By: Jacob S. Zweig
Jacob S. Zweig

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This is in response to the Office Action mailed September 15, 2003, in the referenced application. Please amend the claims as indicate below and consider the following remarks.

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 18 of this paper.

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